

Notice of References Cited

Application/Control No.

10/687,746

Applicant(s)/Patent Under
Reexamination
ITO ET AL.

Examiner

Chad Dickerson

Art Unit

2625

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,198,526	03-2001	Ohtsuka, Shuichi	355/40
*	B	US-2002/0196346	12-2002	Nishio et al.	348/207.2
*	C	US-2004/0201689	10-2004	Quintana et al.	348/207.1
*	D	US-2003/0035127	02-2003	Nakami, Yoshihiro	358/1.9
*	E	US-2002/0135687	09-2002	Nakajima et al.	348/231.3
*	F	US-2002/0140693	10-2002	Nakami et al.	345/418
*	G	US-6,011,547	01-2000	Shiota et al.	382/254
*	H	US-5,974,401	10-1999	Enomoto et al.	705/40
*	I	US-6,115,137	09-2000	Ozawa et al.	358/1.6
*	J	US-6,867,882	03-2005	Takahashi, Fumiaki	358/1.6
*	K	US-6,307,640	10-2001	Motegi, Akihiko	358/1.14
*	L	US-7,196,813	03-2007	Matsumoto, Keizaburo	358/1.3
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2004139385 A	05-2004	Japan	KADOI et al.	
	O	JP 2004139386 A	05-2004	Japan	AOKI et al.	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.